Search Notes



Applicat	ion/Contro	l No.
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10/705,901 Examiner

Joseph Nguyen

Applicant(s)/Patent under Reexamination

HIROHATA ET AL.

Art Unit

2815

SEARCHED				
Class	Subclass	Date	Examiner	
257	10	1/14/2005	JN	
257	81,99	1/14/2005	JN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
257	10	1/14/2005	JN	
257	81,99	1/14/2005	JN	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST	1/14/2005	JN
(photocathode) and (semiconductor)	1/14/2005	JN
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